

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10593561	NONAKA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	SHIN-HON CHEN	2431

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
380	251, 259	9/25/08	S.C.
713	193	9/25/08	S.C.

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search- see search history)	9/25/08	S.C.
NPL search (google)	9/25/08	S.C.
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search- updated search)	2/25/09	S.C.

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
713	179-181, 193	2/26/09	S.C.
380	251, 259	2/26/09	S.C.
707	100, 101	2/26/09	S.C.

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